



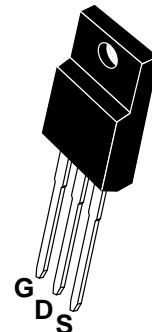
First Semiconductor

N-Channel Power MOSFET

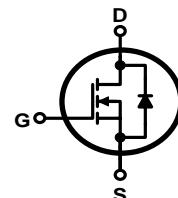
FIR2N60AFG

PIN Connection TO-220F

V _{DSS}	600	V
I _D	2	A
P _D (T _C =25°C)	35	W
R _{DS(ON)}	4.5	Ω



Schematic diagram



Marking Diagram



Y = Year
 A = Assembly Location
 WW = Work Week
 FIR2N60AF = Specific Device Code

Applications

Power switch circuit of adaptor and charger.

Absolute (T_c= 25°C unless otherwise specified)

Symbol	Parameter	Rating	Units
V _{DSS}	Drain-to-Source Voltage	600	V
I _D	Continuous Drain Current	2.0	A
	Continuous Drain Current T _C = 100 °C	1.26	A
I _{DM} ^{a1}	Pulsed Drain Current	8.0	A
V _{GS}	Gate-to-Source Voltage	±30	V
E _{AS} ^{a2}	Single Pulse Avalanche Energy	100	mJ
E _{AR} ^{a1}	Avalanche Energy ,Repetitive	6.4	mJ
I _{AR} ^{a1}	Avalanche Current	3.6	A
dv/dt ^{a3}	Peak Diode Recovery dv/dt	5	V/ns
P _D	Power Dissipation	35	W
	Derating Factor above 25°C	0.28	W/°C
T _J , T _{stg}	Operating Junction and Storage Temperature Range	150, -55 to 150	°C
T _L	MaximumTemperature for Soldering	300	°C

**Electrical Characteristics** (T_c= 25°C unless otherwise specified)**OFF Characteristics**

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V _{DSS}	Drain to Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	600	--	--	V
Δ BV _{DSS} / Δ T _J	Bvdss Temperature Coefficient	ID=250uA, Reference 25°C	--	0.7	--	V/°C
I _{DSS}	Drain to Source Leakage Current	V _{DS} = 600V, V _{GS} = 0V, T _a = 25°C	--	--	25	μA
		V _{DS} = 480V, V _{GS} = 0V, T _a = 125°C			250	
I _{GSS(F)}	Gate to Source Forward Leakage	V _{DS} = 0V, V _{GS} = 30V	--	--	100	nA
I _{GSS(R)}	Gate to Source Reverse Leakage	V _{GS} = -30V	--	--	-100	nA

ON Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
R _{DS(ON)}	Drain-to-Source On-Resistance	V _{GS} =10V, I _D =1.0A	--	3.74	4.5	Ω
V _{GS(TH)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250μA	2.0	3.0	4.0	V
Pulse width t _p ≤ 380μs, δ ≤ 2%						

Dynamic Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
g _{fs}	Forward Transconductance	V _{DS} =15V, I _D = 1.0A	2.0	--	--	S
C _{iss}	Input Capacitance	V _{GS} = 0V V _{DS} = 25V f = 1.0MHz	--	280	--	pF
C _{oss}			--	30	--	
C _{rss}			--	3.8	--	

Resistive Switching Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
t _{d(ON)}	Turn-on Delay Time	I _D = 2.0A V _{DD} = 300V V _{GS} = 10V R _G = 18Ω	--	7.8	--	ns
tr	Rise Time		--	5.5	--	
t _{d(OFF)}	Turn-Off Delay Time		--	33	--	
t _f	Fall Time		--	16	--	
Q _g	Total Gate Charge	I _D = 2.0A V _{DD} = 480V V _{GS} = 10V	--	8.5	--	nC
Q _{gs}	Gate to Source Charge		--	1.5	--	
Q _{gd}	Gate to Drain ("Miller") Charge		--	4.0	--	

**Source-Drain Diode Characteristics**

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I _S	Continuous Source Current (Body Diode)		--	--	2	A
I _{SM}	Maximum Pulsed Current (Body Diode)		--	--	8	A
V _{SD}	Diode Forward Voltage	I _S =2.0A, V _{GS} =0V	--	--	1.5	V
trr	Reverse Recovery Time	I _S =2.0A, T _j = 25° C dI _F /dt=100A/us, V _{GS} =0V	--	285	--	ns
Qrr	Reverse Recovery Charge		--	750	--	nC
I _{RRM}	Reverse Recovery Current		--	5.2	--	A

Pulse width tp ≤ 380μs, δ ≤ 2%

Symbol	Parameter	Typ.	Units
R _{θ JC}	Junction-to-Case	3.57	°C/W
R _{θ JA}	Junction-to-Ambient	120	°C/W

^{a1}: Repetitive rating; pulse width limited by maximum junction temperature^{a2}: L=10.0mH, I_D=2A, Start T_j=25°C^{a3}: I_{SD}=2A, di/dt ≤ 100A/us, V_{DD}≤BV_{DS}, Start T_j=25°C

Characteristic Curves

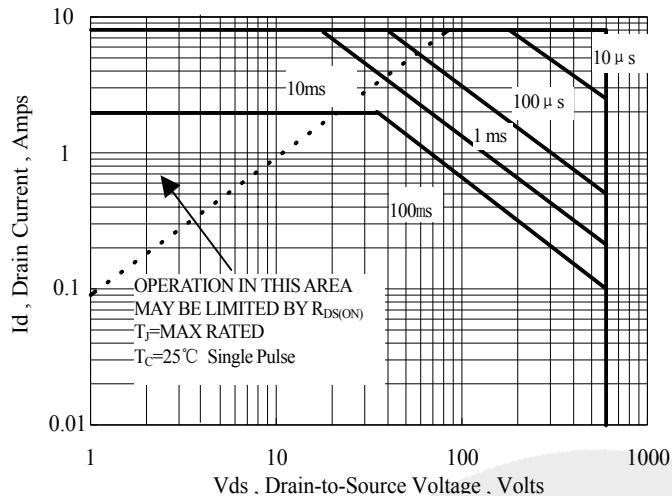


Figure 1 Maximum Forward Bias Safe Operating Area

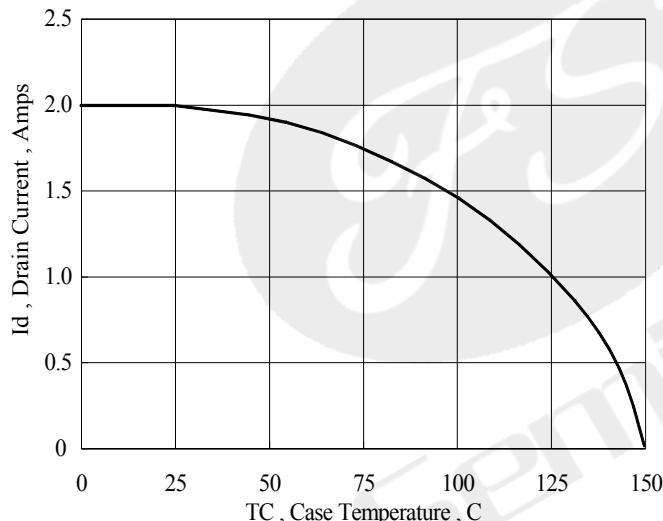


Figure 3 Maximum Continuous Drain Current vs Case Temperature

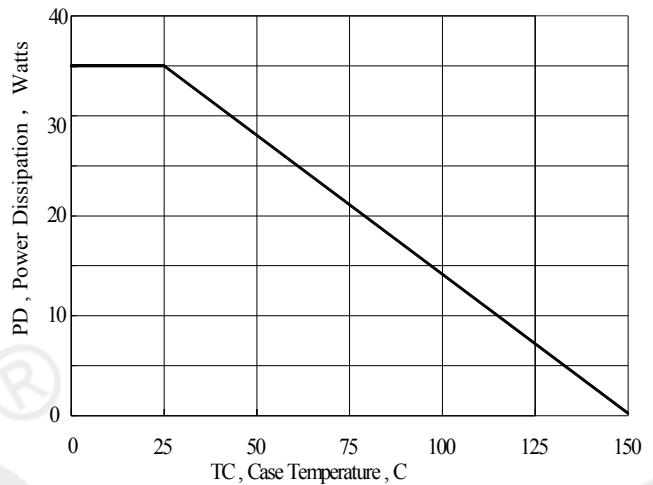


Figure 2 Maximum Power Dissipation vs Case Temperature

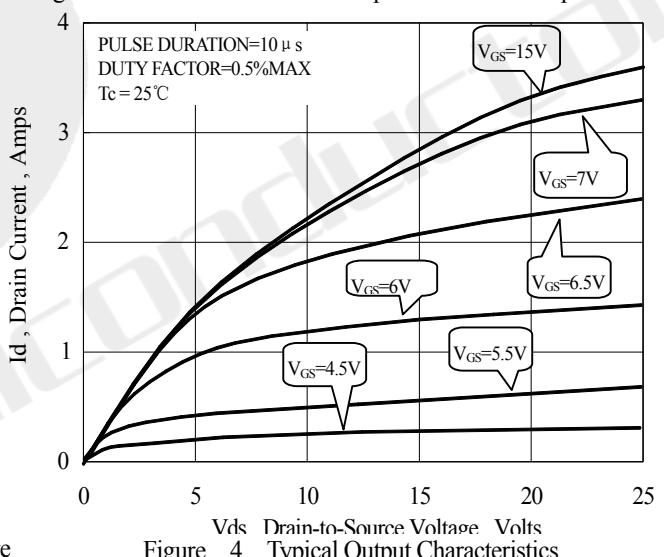


Figure 4 Typical Output Characteristics

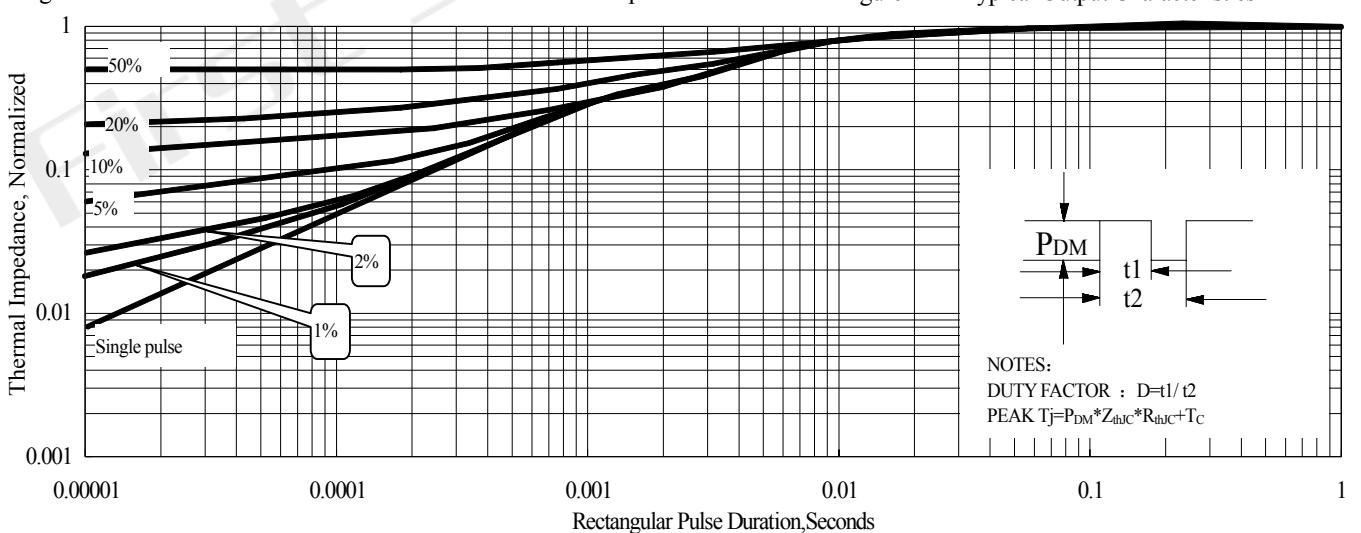
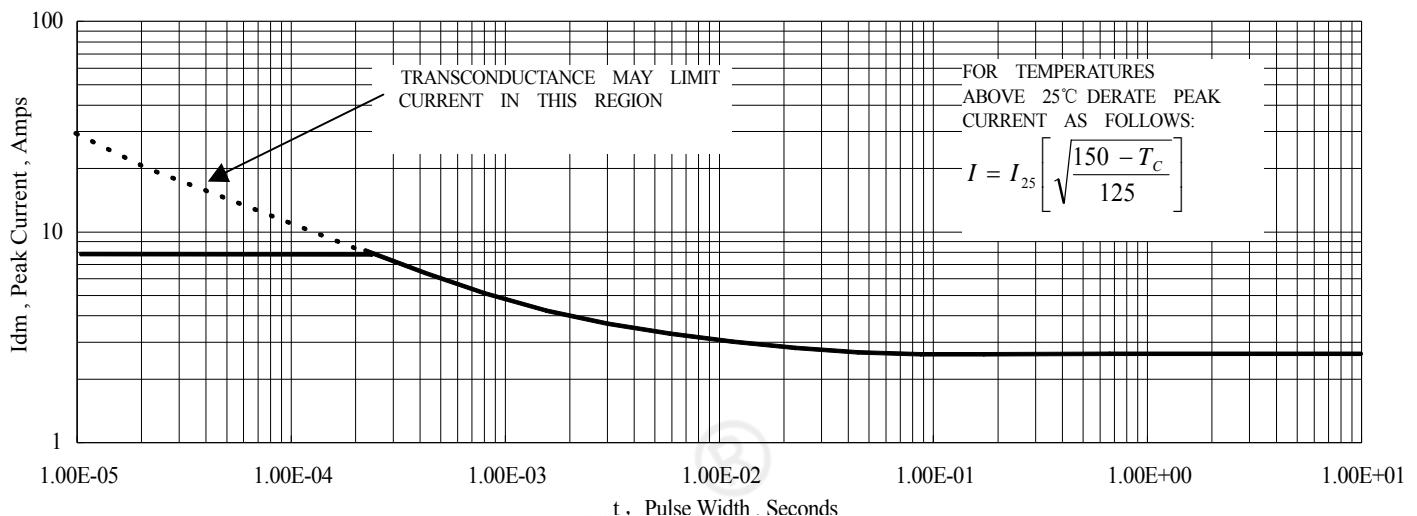
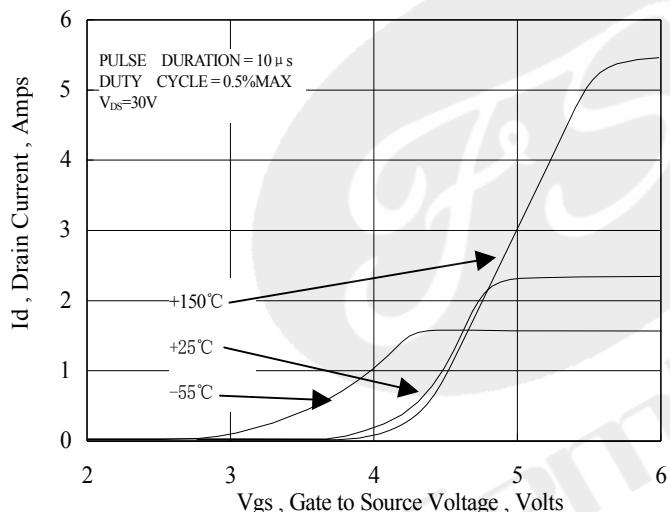
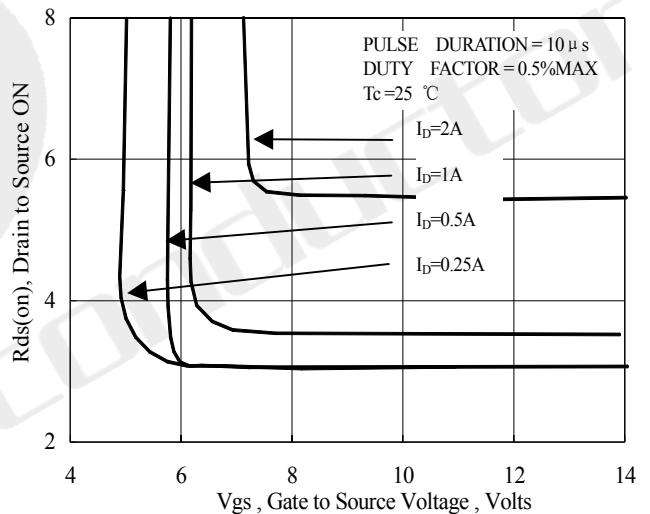
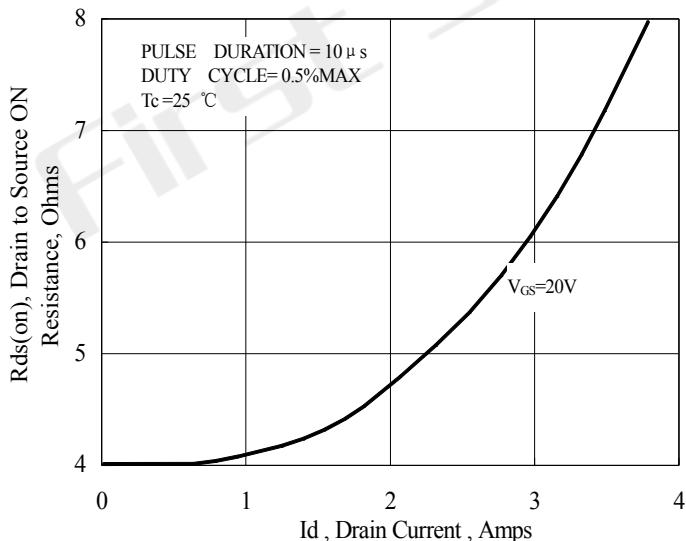
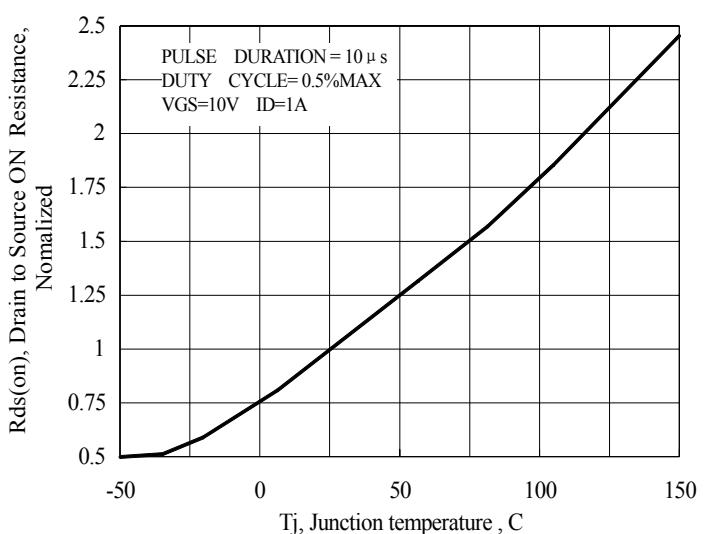


Figure 5 Maximum Effective Thermal Impedance , Junction to Case


Figure 6 Maximum Peak Current Capability

Figure 7 Typical Transfer Characteristics

Figure 8 Typical Drain to Source ON Resistance vs Gate Voltage and Drain Current

Figure 9 Typical Drain to Source ON Resistance vs Drain Current

Figure 10 Typical Drian to Source on Resistance vs Junction Temperature

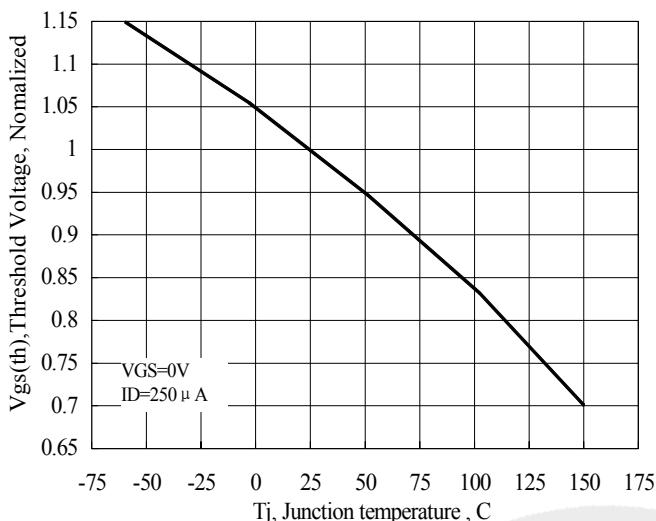


Figure 11 Typical Threshold Voltage vs Junction Temperature

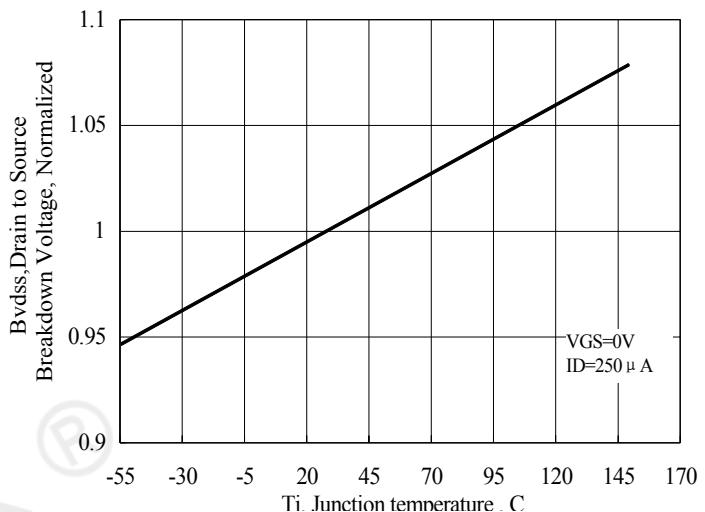


Figure 12 Typical Breakdown Voltage vs Junction Temperature

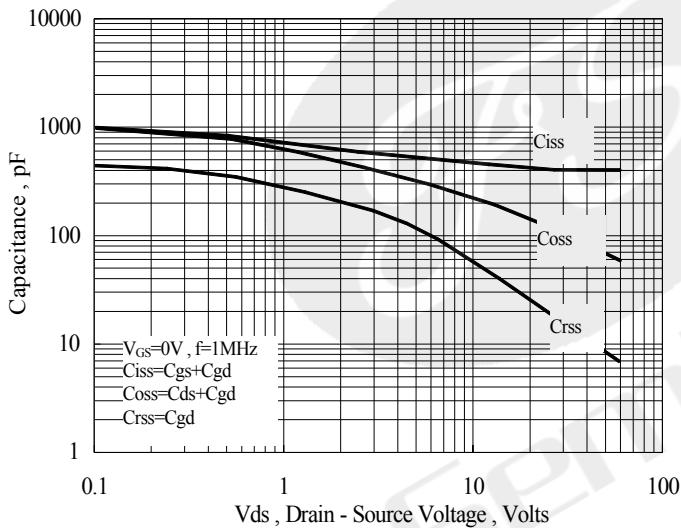


Figure 13 Typical Capacitance vs Drain to Source Voltage

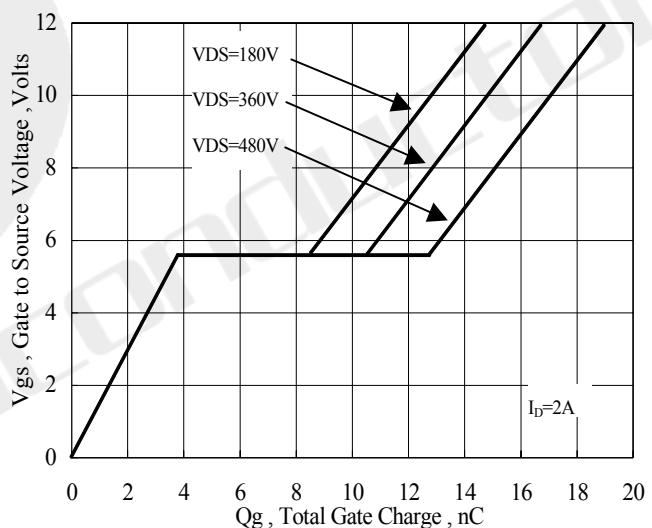


Figure 14 Typical Gate Charge vs Gate to Source Voltage

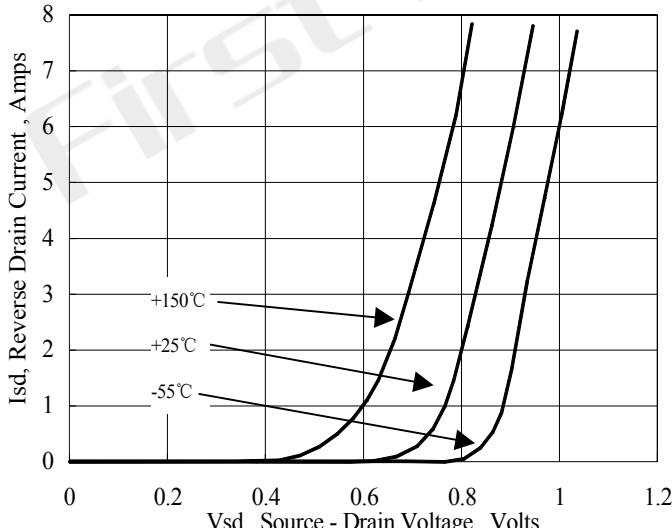


Figure 15 Typical Body Diode Transfer Characteristics

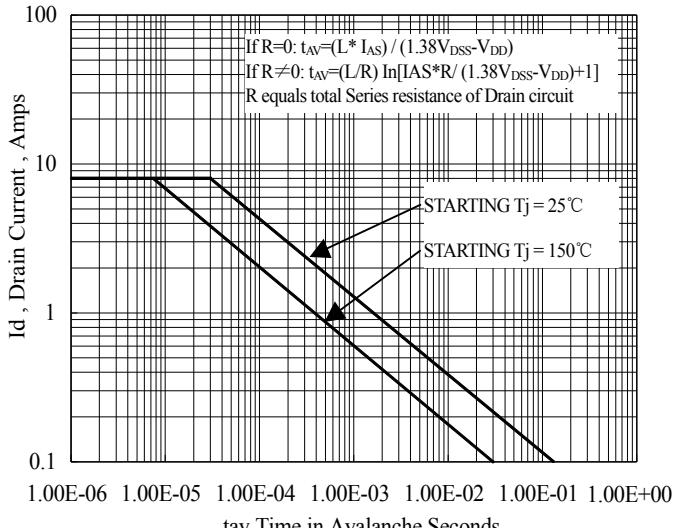
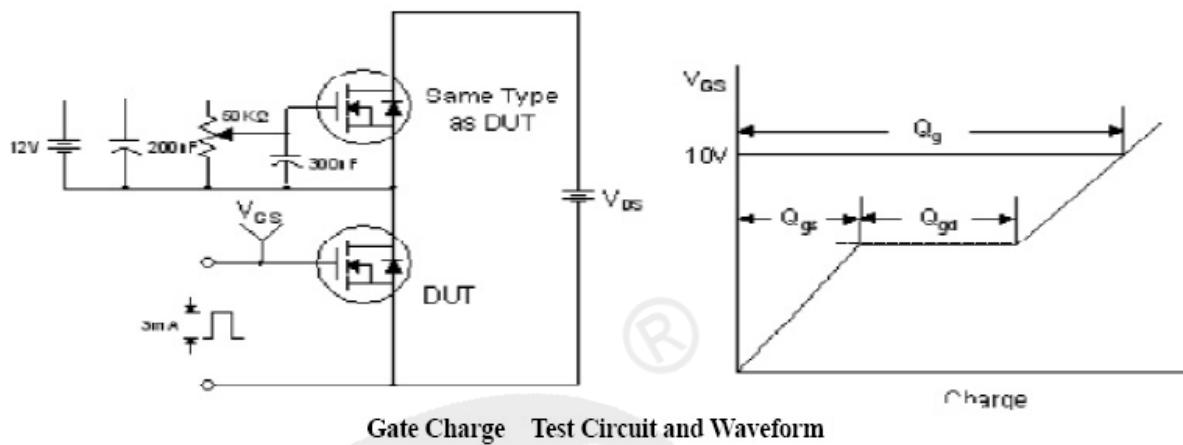


Figure 16 Unclamped Inductive Switching Capability

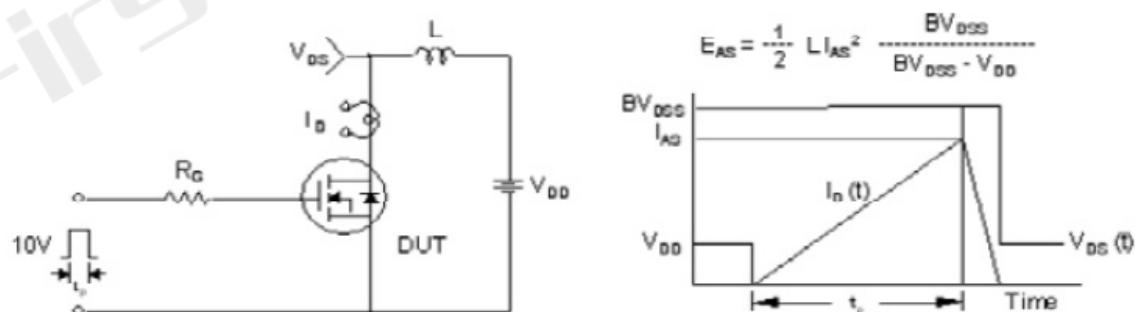
Test Circuit and Waveform



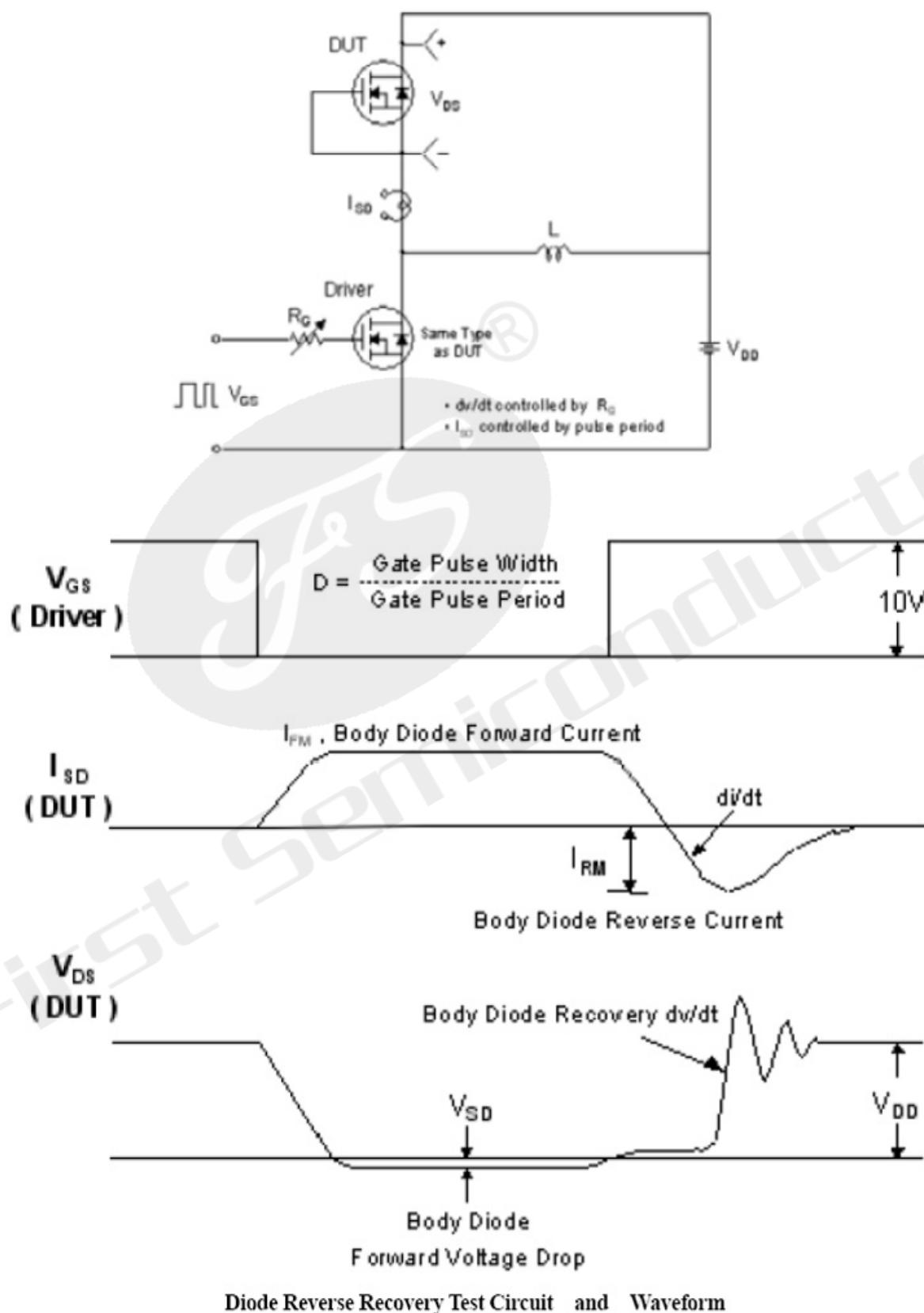
Gate Charge Test Circuit and Waveform



Resistive Switching Test Circuit and Waveform

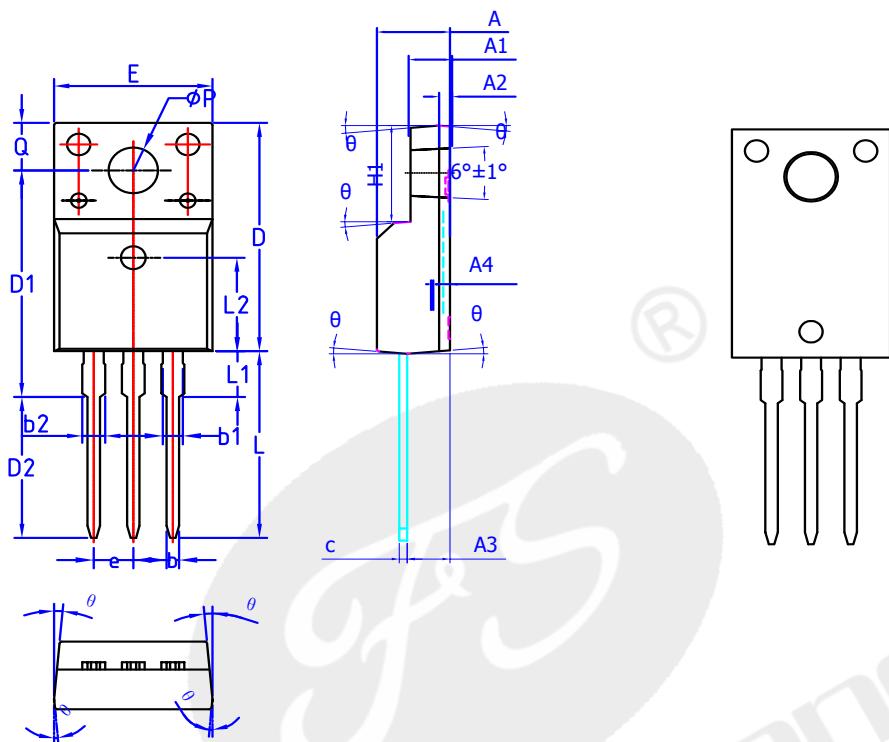


Unclamped Inductive Switching Test Circuit and Waveform



Package Dimensions

TO-220F


 COMMON DIMENSIONS
(UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	NOM	MAX
A	4.50	4.70	4.90
A1	2.34	2.54	2.74
A2		0.70 REF	
A3	2.56	2.76	2.96
b	0.70	0.80	0.90
b1	1.17	1.2	1.25
b2	1.17	1.2	1.25
c	0.45	0.50	0.60
D	15.67	15.87	16.07
D1	15.55	15.75	15.95
D2	10.0	10.2	10.4
E	9.96	10.16	10.36
e		2.54BSC	
H1	6.48	6.68	6.88
L	12.68	12.98	13.28
L1	—	—	3.50
L2		6.50REF	
ΦP	3.08	3.18	3.28
Q	3.20	3.30	3.40
θ 1	1°	3°	5°
A4	0.53	0.56	0.59



Declaration

- FIRST reserves the right to change the specifications, the same specifications of products due to different packaging line mold, the size of the appearance will be slightly different, shipped in kind, without notice! Customers should obtain the latest version information before ordering, and verify whether the relevant information is complete and up-to-date.
- Any semiconductor product under certain conditions has the possibility of failure or failure, The buyer has the responsibility to comply with safety standards and take safety measures when using FIRST products for system design and manufacturing, To avoid potential failure risks, which may cause personal injury or property damage!
- Product promotion endless, our company will wholeheartedly provide customers with better products!

ATTACHMENT

Revision History

Date	REV	Description	Page
2018.01.01	1.0	Initial release	